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Standards

Irish Standard
I.S. EN 62149-2:2014

Fibre optic active components and devices -
Performance standards - Part 2: 850 nm
discrete vertical cavity surface emitting laser
devices

I.S. EN 62149-2:2014

Incorporating amendments/corrigenda/National Annexes issued since publication:

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NSAI
1 Swift Square,
Northwood, Santry
Dublin 9

T +353 1 807 3800
F +353 1 807 3838
E standards@nsai.ie
W NSAI.ie

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NORME EUROPÉENNE

EUROPÄISCHE NORM

August 2014

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Supersedes EN 62149-2:2009

English Version

**Fibre optic active components and devices - Performance standards - Part 2: 850 nm discrete vertical cavity surface emitting laser devices
(IEC 62149-2:2014)**

Composants et dispositifs actifs à fibres optiques - Normes de performances - Partie 2: Dispositifs discrets à laser 850 nm à cavité verticale émettant en surface
(CEI 62149-2:2014)

Aktive Lichtwellenleiterbauelemente und geräte - Betriebsverhalten - Teil 2: Oberflächenemittierende 850-nm-Laserbauelemente mit Vertikalresonator
(IEC 62149-2:2014)

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Europäisches Komitee für Elektrotechnische Normung

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Foreword

The text of document 86C/1146/CDV, future edition 2 of IEC 62149-2, prepared by SC 86C "Fibre optic systems and active devices" of IEC/TC 86 "Fibre optics" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62149-2:2014.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2015-03-30
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2017-06-30

This document supersedes EN 62149-2:2009.

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In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60191	NOTE	Harmonized in EN 60191 Series.
IEC 60747-5-1	NOTE	Harmonized as EN 60747-5-1.
IEC 60749	NOTE	Harmonized in EN 60749 Series.
IEC 60825	NOTE	Harmonized in EN 60825 Series.
IEC 60874	NOTE	Harmonized in EN 60874 Series.
IEC 61280-1-3	NOTE	Harmonized as EN 61280-1-3.
IEC 62007-1	NOTE	Harmonized as EN 62007-1.
IEC 62007-2	NOTE	Harmonized as EN 62007-2.
IEC 62148-1	NOTE	Harmonized as EN 62148-1.
IEC 62149-1	NOTE	Harmonized as EN 62149-1.

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60749-6	-	Semiconductor devices - Mechanical and climatic test methods - Part 6: Storage at high temperature	EN 60749-6	-
IEC 60749-7	-	Semiconductor devices - Mechanical and climatic test methods - Part 7: Internal moisture content measurement and the analysis of other residual gases	EN 60749-7	-
IEC 60749-10	-	Semiconductor devices - Mechanical and climatic test methods - Part 10: Mechanical shock	EN 60749-10	-
IEC 60749-11	-	Semiconductor devices - Mechanical and climatic test methods - Part 11: Rapid change of temperature - Two-fluid-bath method	EN 60749-11	-
IEC 60749-12	-	Semiconductor devices - Mechanical and climatic test methods - Part 12: Vibration, variable frequency	EN 60749-12	-
IEC 60749-25	-	Semiconductor devices - Mechanical and climatic test methods - Part 25: Temperature cycling	EN 60749-25	-
IEC 60749-26	-	Semiconductor devices - Mechanical and climatic test methods - Part 26: Electrostatic discharge (ESD) sensitivity testing - Human body model (HBM)	EN 60749-26	-
IEC 60825-1	-	Safety of laser products - Part 1: Equipment classification and requirements	EN 60825-1	-
IEC 60950-1	-	Information technology equipment - Safety - Part 1: General requirements	EN 60950-1	-
IEC 61300-2-4	-	Fibre optic interconnecting devices and passive components - Basic test and measurement procedures - Part 2-4: Tests - Fibre/cable retention	EN 61300-2-4	-
IEC 61300-2-19	-	Fibre optic interconnecting devices and passive components - Basic test and measurement procedures - Part 2-19: Tests - Damp heat (steady state)	EN 61300-2-19	-

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<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61300-2-48	-	Fibre optic interconnecting devices and passive components - Basic test and measurement procedures - Part 2-48: Tests - Temperature-humidity cycling	EN 61300-2-48	-
IEC 62148-15	-	Fibre optic active components and devices - Package and interface standards - Part 15: Discrete vertical cavity surface emitting laser packages	EN 62148-15	-
IEC Guide 107	-	Electromagnetic compatibility - Guide to the drafting of electromagnetic compatibility publications	-	-



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INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Fibre optic active components and devices – Performance standards –
Part 2: 850 nm discrete vertical cavity surface emitting laser devices**

**Composants et dispositifs actifs à fibres optiques – Normes de performances –
Partie 2: Dispositifs discrets à laser 850 nm à cavité verticale émettant
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IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
Fax: +41 22 919 03 00
info@iec.ch
www.iec.ch

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IEC 62149-2

Edition 2.0 2014-05

INTERNATIONAL STANDARD

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Part 2: 850 nm discrete vertical cavity surface emitting laser devices**

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Partie 2: Dispositifs discrets à laser 850 nm à cavité verticale émettant
en surface**

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**FIBRE OPTIC ACTIVE COMPONENTS AND DEVICES –
PERFORMANCE STANDARDS –****Part 2: 850 nm discrete vertical cavity surface emitting laser devices**

FOREWORD

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International Standard IEC 62149-2 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

This second edition cancels and replaces the first edition published in 2009 and constitutes a technical revision.

The significant technical changes with respect to the previous edition include the introduction of the performance standards for 10 Gbit/s 850-nm wavelength, vertical cavity surface emitting laser (VCSEL) devices and the deletion of the package diagrams and pin configurations in Clause A.4 and Clause B.4 by citing the VCSEL package standard IEC 62148-15 instead.

The text of this standard is based on the following documents:

CDV	Report on voting
86C/1146/CDV	86C/1229/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62149 series, published under the general title *Fibre optic active components and devices – Performance standards*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

INTRODUCTION

Fibre optic laser devices are used to convert electrical signals into optical signals. This part of IEC 62149 covers the performance specification for 850 nm discrete vertical cavity surface emitting laser devices in fibre optic telecommunication and optical data transmission applications.

FIBRE OPTIC ACTIVE COMPONENTS AND DEVICES – PERFORMANCE STANDARDS –

Part 2: 850 nm discrete vertical cavity surface emitting laser devices

1 Scope

This part of IEC 62149 covers the performance specification for 850-nm discrete vertical cavity surface emitting laser (VCSEL) devices of transverse multimode types used for fibre optic telecommunication and optical data transmission applications. The performance standard contains a definition of the product performance requirements together with a series of sets of tests and measurements with clearly defined conditions, severities, and pass/fail criteria. The tests are intended to be run on a “once-off” basis to prove any product’s ability to satisfy the performance standard’s requirements.

A product that has been shown to meet all the requirements of a performance standard can be declared as complying with the performance standard, but should then be controlled by a quality assurance/quality conformance program.

Depending on the modulation speeds, sub-categorized specifications are defined. Types A1, A2, A3 and A4 correspond to 1,25 Gbit/s, 2,5 Gbit/s, 4,25 Gbit/s and 10 Gbit/s VCSELs, respectively.

Each sub-categorized specification is also defined by separate details depending on the device types, such as specifications for a VCSEL device without a monitor photodiode (case a) and for a VCSEL device with a monitor photodiode (case b).

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60749-6, *Semiconductor devices – Mechanical and climatic test methods – Part 6: Storage at high temperature*

IEC 60749-7, *Semiconductor devices – Mechanical and climatic test methods – Part 7: Internal moisture content measurement and the analysis of other residual gases*

IEC 60749-10, *Semiconductor devices – Mechanical and climatic test methods – Part 10: Mechanical shock*

IEC 60749-11, *Semiconductor devices – Mechanical and climatic test methods – Part 11: Rapid change of temperature – Two-fluid-bath method*

IEC 60749-12, *Semiconductor devices – Mechanical and climatic test methods – Part 12: Vibration, variable frequency*

IEC 60749-25, *Semiconductor devices – Mechanical and climatic test methods – Part 25: Temperature cycling*

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